Application/Control No. Applicant(s)/Patent Under Reexamination 10/787,347 KIMURA, HAJIME Notice of References Cited Art Unit Examiner Page 1 of 1 2816 Hiep Nguyen **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-6,525,574 02-2003 Herrera, Ruben 327/94 Α US-В US-С D US-Ε US-F US-US-G US-Н US-1 J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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